

#### DESCRIPTION

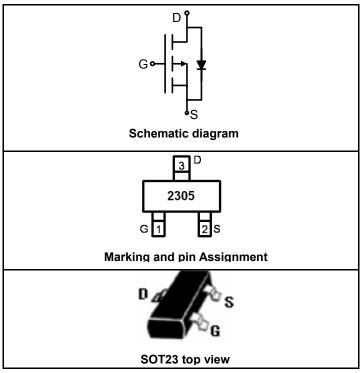
The SSF2305 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 0.5V. This device is suitable for use as a load switch or in PWM applications.

### **GENERAL FEATURES**

- $V_{DS}$  = -20V, $I_{D}$  = -3A  $R_{DS(ON)}$  < 114mΩ @  $V_{GS}$ =-2.5V  $R_{DS(ON)}$  < 89mΩ @  $V_{GS}$ =-4.5V
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

# **Application**

- ●PWM applications
- Load switch
- Power management



#### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
2305	SSF2305	SOT23	-	-	-

### ABSOLUTE MAXIMUM RATINGS(TA=25 ℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	-20	V	
Gate-Source Voltage	Vgs	±12	V	
	I <sub>D</sub> (25℃)	-3	А	
Drain Current-Continuous@ Current-Pulsed (Note 1)	I <sub>D</sub> (70℃)	-1.8	А	
	I <sub>DM</sub>	-10	А	
Maximum Power Dissipation	P <sub>D</sub>	1.25	W	
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$	

### THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	100	°C/W
·			

## ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-20			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V			-1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±12V,V <sub>DS</sub> =0V			±100	nA



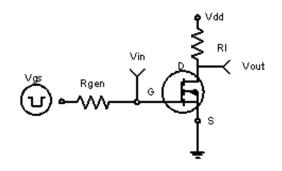
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250μA	-0.5		-1	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A		62 89		mΩ
Diani-Source Oil-State Resistance		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-2A		88	114	11122
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =-5V,I <sub>D</sub> =-3A		7		S
DYNAMIC CHARACTERISTICS (Note4)	DYNAMIC CHARACTERISTICS (Note4)					
Input Capacitance	C <sub>lss</sub>	V <sub>DS</sub> =-10V,V <sub>GS</sub> =0V, F=1.0MHz		1160		PF
Output Capacitance	C <sub>oss</sub>			210		PF
Reverse Transfer Capacitance	C <sub>rss</sub>			125		PF
SWITCHING CHARACTERISTICS (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>			13.6	27.2	nS
Turn-on Rise Time	t <sub>r</sub>	V <sub>DD</sub> =-10V,I <sub>D</sub> =-3A V <sub>GS</sub> =-4.5V,R <sub>GEN</sub> =3Ω		8.6	17.2	nS
Turn-Off Delay Time	t <sub>d(off)</sub>			73.6	147.2	nS
Turn-Off Fall Time	t <sub>f</sub>			34.6	69.2	nS
Total Gate Charge	Qg			9.6	12.7	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-10V,I <sub>D</sub> =-3A,V <sub>GS</sub> =-4.5V		1.1		nC
Gate-Drain Charge	$Q_{gd}$			2.6		nC
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-1A			-1.2	V

## **NOTES:**

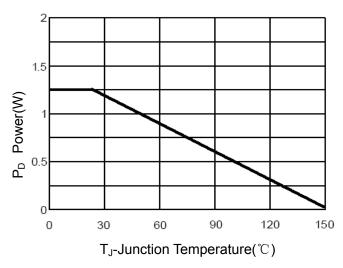
- Repetitive Rating: Pulse width limited by maximum junction temperature.
  Surface Mounted on 1in² FR4 Board, t ≤ 10 sec.
  Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
  Guaranteed by design, not subject to production testing.



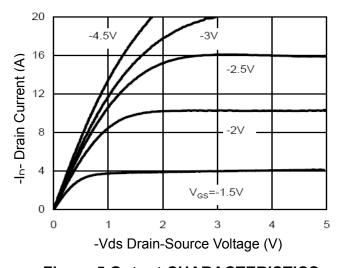
# TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



**Figure 1:Switching Test Circuit** 



**Figure 3 Power Dissipation** 



**Figure 5 Output CHARACTERISTICS** 

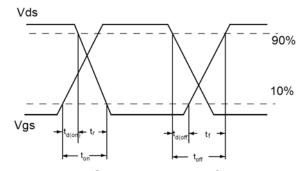
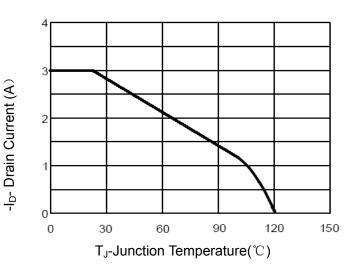


Figure 2:Switching Waveforms



**Figure 4 Drain Current** 

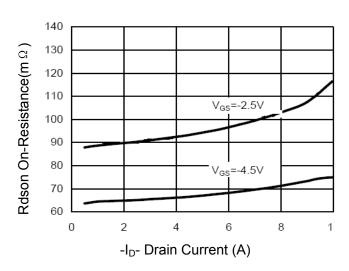
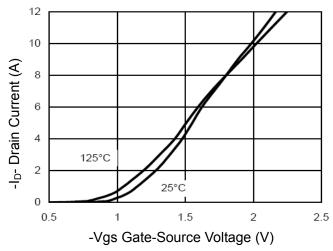


Figure 6 Drain-Source On-Resistance





**Figure 7 Transfer Characteristics** 

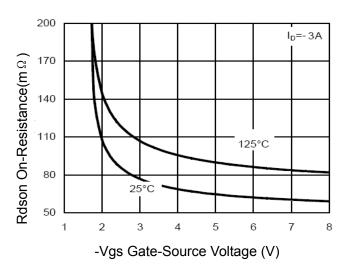


Figure 9 Rdson vs Vgs

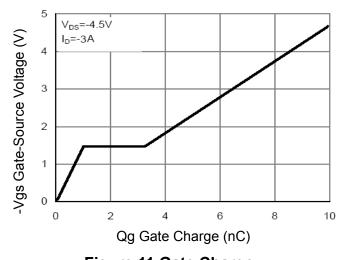


Figure 11 Gate Charge

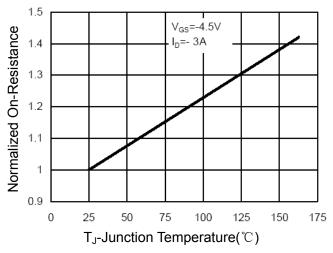


Figure 8 Drain-Source On-Resistance

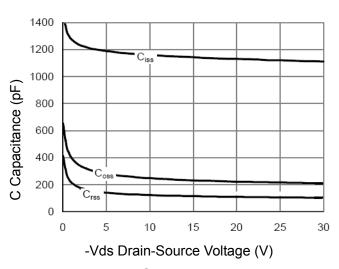


Figure 10 Capacitance vs Vds

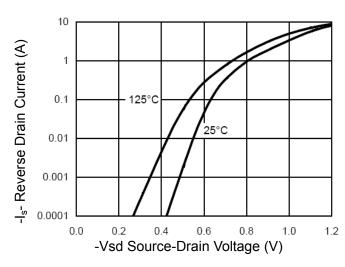


Figure 12 Source- Drain Diode Forward



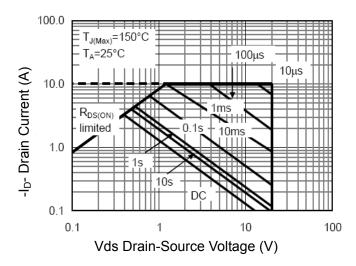


Figure 13 Safe Operation Area

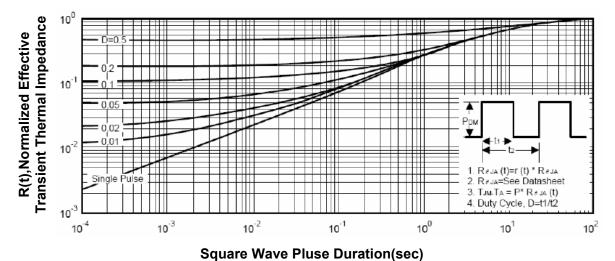
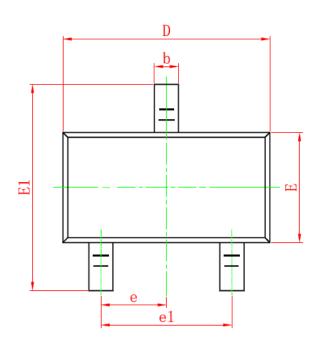


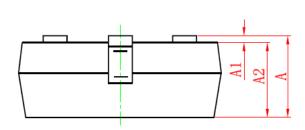
Figure 14 Normalized Maximum Transient Thermal Impedance

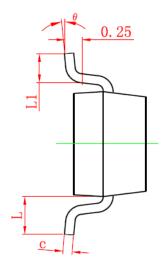


# **SOT-23 PACKAGE INFORMATION**

**Dimensions in Millimeters (UNIT:mm)** 







Cumbal	Dimensions in Millimeters			
Symbol	MIN.	MAX.		
Α	0.900	1.150		
A1	0.000	0.100		
A2	0.900	1.050		
b	0.300	0.500		
С	0.080	0.150		
D	2.800	3.000		
E	1.200	1.400		
E1	2.250	2.550		
е	0.950TYP			
e1	1.800 2.000			
L	0.550REF			
L1	0.300 0.500			
θ	0°	8°		

# **NOTES**

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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